

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/458,768 BYERS ET AL.	
		Examiner	Art Unit	Page 1 of 1 David Odland 2662

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,125,117	09-2000	Martin et al.	370/397
	B	US-6,111,879	08-2000	Choi, Yong-Shik	370/395.61
	C	US-5,889,773	03-1999	Stevenson, III, K. Martin	370/352
	D	US-5,327,421	07-1994	Hiller et al.	370/395.61
	E	US-5,170,272	12-1992	Onno, Guy	370/534
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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